UTC MCR100 SCR

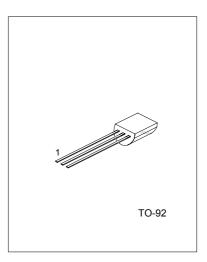
SENSITIVE GATE SILICON **CONTROLLED RECTIFIERS REVERSE BLOCKING THYRISTORS**

DESCRIPTION

PNPN devices designed for high volume, line-powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in an inexpensive plastic TO-92 package which is readily adaptable for use in automatic insertion equipment.

DESCRIPTION

- *Sensitive Gate Allows Triggering by Micro controllers and Other Logic circuits
- *Blocking Voltage to 600V
- *On-State Current Rating of 0.8A RMS at 80°C
- *High Surge Current Capability 10A
- *Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- *Immunity to dV/dt 20V/µsec Minimum at 110°C
- *Glass-Passivated Surface for Reliability and Uniformity



1:CATHODE 2:GATE 3:ANODE

THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	MAX	UNIT
Thermal Resistance, Junction to Case	$R_{ heta JC}$	75	°C/W
Thermal Resistance, Junction to Ambient	$R_{\scriptscriptstyle{ hetaJA}}$	200	°C/W
Lead Solder Temperature	T _L	260	°C
(<1/16" from case, 10 secs max)			

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	MAX	UNIT
Peak Repetitive Off-State Voltage(note)	VDRM,VRRM		V
(T _J =-40 to 110°C, Sine Wave, 50 to 60Hz; Gate Open)			
MCR100-4		200	
MCR100-6		400	
MCR100-8		600	
On-Sate RMS Current	IT(RMS)	0.8	Α
(Tc=80°C) 180° Condition Angles			
Peak Non-Repetitive Surge Current	ITSM	10	Α
(1/2 cycle, Sine Wave, 60Hz, T _J =25°C)			

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PARAMETER	SYMBOL	MAX	UNIT
Circuit Fusing Considerations	l ² t	0.415	A ² s
(t=8.3 ms)			
Forward Peak Gate Power	Рдм	0.1	W
(T _A =25°C, Pulse Width ≤1.0μs)			
Forward Average Gate Power	PG(AV)	0.1	W
(T _A =25°C, t=8.3ms)			
Peak Gate Current – Forward	IGМ	1	Α
(T _A =25°C, Pulse Width≤1.0μs)			
Peak Gate Voltage – Reverse	VGRM	5	V
(T _A =25°C, Pulse Width≤1.0μs)			
Operating Junction Temperature Range @ Rated V _{RRM} and	TJ	-40 to +110	°C
V_{DRM}			
Storage Temperature Range	Tstg	-40 to +150	°C

Note: V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

ELECTRICAL CHARACTERISTICS (Ti=25°C, unless otherwise stated)

PARAMETER TEST CONDITION SYMBOL MIN TYP MAX UNIT						
PARAMETER	TEST CONDITION	SYMBOL	TYP	MAX	UNIT	
OFF CHARACTERISTICS						•
Peak Forward or Reverse Blocking	V_D =Rated V_{DRM} and V_{RRM} ; R_{GK} =1k Ω	I _{DRM} , I _{RRM}				
Current Tc=25°C					10	μΑ
Tc=125°C					100	μΑ
ON CHARACTERISTICS						
Peak Forward On-State Voltage	I _{TM} =1A Peak @ T _A =25°C	V_{TM}			1.7	V
(Note1)						
Gate Trigger Current (Continuous	V_{AK} =7Vdc, R_L =100 Ω , T_C =25°C	I_{GT}		40	200	μΑ
dc)(note2)						
Holding Current (note 3) Tc=25 °C	V _{AK} =7Vdc, initiating current=20mA	I _H		0.5	5	mA
Tc=-40 °C					10	
Latch Current Tc=25 °C	V _{AK} =7V, Ig=200μA	ΙL		0.6	10	mA
Tc=-40 °C					15	
Gate Trigger Current	V_{AK} =7Vdc, R_L =100 Ω	V_{GT}				V
(continuous dc) (Note 2) Tc=25 °C				0.62	0.8	
Tc=-40 °C					1.2	
DYNAMIC CHARACTERISTICS						
Critical Rate of Rise of Off-State	V _D =Rated V _{DRM} , Exponential	dV/dt	20	35		V/μs
Voltage	Waveform, R _{GK} =1000Ω, T _J =110°C					
Critical Rate of Rise of On-State	I _{PK} =20A; Pw=10μsec;	di/dt			50	A/μs
Current	diG/dt=1A/μsec, Igt=20mA					

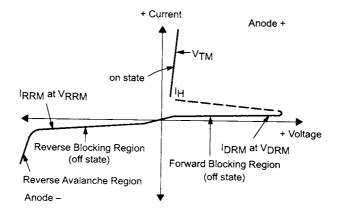
Notes: 1. Indicates Pulse Test Width≤1.0ms, duty cycle ≤1%

- 2. $R_{\text{GK}}\text{=}1000\Omega$ included in measurement.
- 3. Does not include R_{GK} in measurement.

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VOLTAGE CURRENT CHARACTERISTIC OF SCR

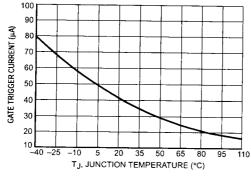
SYMBOL	PARAMETER		
V_{DRM}	Peak Repetitive Off Stat Forward Voltage		
I _{DRM}	Peak Forward Blocking Current		
V_{RRM}	Peak Repetitive Off State Reverse Voltage		
I _{RRM}	Peak Reverse Blocking Current		
V_{TM}	Peak On State Voltage		
I _H	Holding Current		



CLASSIFICATION OF IGT

RANK	В	С	AA	AB	AC	AD
RANGE	48~105μA	95~200μA	8~16μA	14~21μA	19~25μA	23~52μΑ

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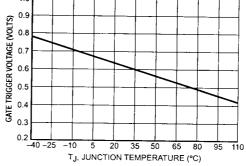
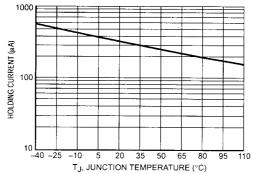


Figure 1. Typical Gate Trigger Current versus **Junction Temperature**

Figure 2. Typical Gate Trigger Voltage versus **Junction Temperature**



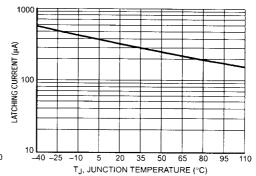
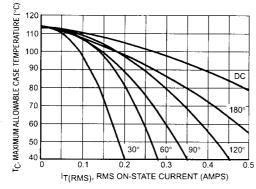


Figure 3. Typical Holding Current versus Junction Temperature

Figure 4. Typical Latching Current versus **Junction Temperature**



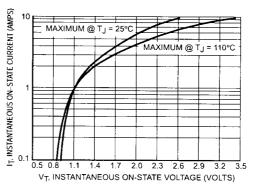


Figure 5. Typical RMS Current Derating

Figure 6. Typical On-State Characteristics

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